

74LVQ157

Low Voltage Quad 2-Input Multiplexer

General Description

The LVQ157 is a high-speed quad 2-input multiplexer. Four bits of data from two sources can be selected using the common Select and Enable inputs. The four outputs present the selected data in the true (noninverted) form. The LVQ157 can also be used as a function generator.

Features

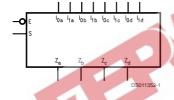
- Ideal for low power/low noise 3.3V applications
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Guaranteed incident wave switching into 75 Ω .

Ordering Code:

Order Number	Package Number	Package Description
74LVQ157SC	M16A	16-Lead (0.150" Wide) Small Outline Integrated Circuit, SOIC JEDEC
74LVQ157SJ M16D		16-Lead Molded Small Outline Package, SOIC EIAJ

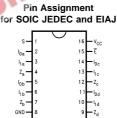
Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbols



DS011352-3

Connection Diagram



Pin Descriptions

Pin Names	Description				
I _{0a} -I _{0d}	Source 0 Data Inputs				
I _{1a} -I _{1d}	Source 1 Data Inputs				
Ē	Enable Input				
S	Select Input				
Z _a -Z _d	Outputs				

Truth Table

,							
	Outputs						
Ē	S	I ₀	I ₁	Z			
Н	Х	Х	Х	L			
L	Н	Х	L	L			
L	Н	X	Н	Н			
L	L	L	Х	L			
1 .	l 1	l н	×	н			

- H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Immateria

Functional Description

The LVQ157 is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S). The Enable input ($\overline{\mathbb{E}}$) is active-LOW. When $\overline{\mathbb{E}}$ is HIGH, all of the outputs (Z) are forced LOW regardless of all other inputs. The LVQ157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$Z_a = \overline{E} \cdot (I_{1a} \cdot S + I_{0a} \cdot \overline{S})$$

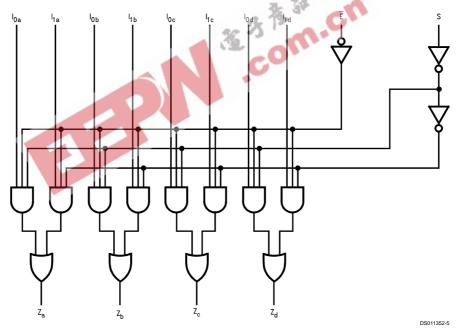
$$Z_b = \overline{E} \cdot (I_{1b} \cdot S + I_{0b} \cdot \overline{S})$$

$$\mathsf{Z}_{\mathtt{c}} = \overline{\mathsf{E}} \bullet (\mathsf{I}_{\mathtt{1c}} \bullet \mathsf{S} + \mathsf{I}_{\mathtt{0c}} \bullet \overline{\mathsf{S}} \,)$$

$$Z_{d} = \overline{\mathsf{E}} \, \bullet \, (\mathsf{I}_{1d} \, \bullet \, \mathsf{S} + \mathsf{I}_{0d} \, \bullet \, \overline{\mathsf{S}} \,)$$

A common use of the LVQ157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The LVQ157 can generate any four of the sixteen different functions of two variables with one variable common. This is useful for implementing gating functions.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC}) -0.5V to +7.0V

DC Input Diode Current (IIK)

 $\begin{array}{c} {\rm V_{I} = -0.5V} & -20 \text{ mA} \\ {\rm V_{I} = V_{CC} + 0.5V} & +20 \text{ mA} \\ {\rm DC \ Input \ Voltage \ (V_{I})} & -0.5V \ {\rm to \ V_{CC} + 0.5V} \\ \end{array}$

DC Output Diode Current (I_{OK})

 $\begin{array}{lll} \mbox{V}_{\mbox{O}} = -0.5\mbox{V} & -20\mbox{ mA} \\ \mbox{V}_{\mbox{O}} = \mbox{V}_{\mbox{CC}} + 0.5\mbox{V} & +20\mbox{ mA} \\ \mbox{DC Output Voltage (V}_{\mbox{O}}) & -0.5\mbox{V to V}_{\mbox{CC}} + 0.5\mbox{V} \end{array}$

DC Output Source

or Sink Current (I_O) ±50 mA

DC V_{CC} or Ground Current

DC Latch-Up Source or

Sink Current ±100 mA

Recommended Operating Conditions (Note 2)

Minimum Input Edge Rate ($\Delta V/\Delta t$)

 V_{IN} from 0.8V to 2.0V

V_{CC} @ 3.0V 125 mV/ns

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V _{cc} (V)	T _A = +25°C		T _A = -40°C to +85°C	Units	Conditions	
			Typ Gua		aranteed Limits	100		
V_{IH}	Minimum High Level	3.0	1.5	2.0	2.0	V	V _{OUT} = 0.1V	
	Input Voltage						or V _{CC} – 0.1V	
V _{IL}	Maximum Low Level	3.0	1.5	0.8	0.8	V	V _{OUT} = 0.1V	
	Input Voltage						or V _{CC} – 0.1V	
V _{OH}	Minimum High Level	3.0	2.99	2.9	2.9	V	I _{OUT} = -50 μA	
	Output Voltage	3.0		2.58	2.48	V	V _{IN} = V _{IL} or V _{IH} (Note 3)	
							I _{OH} = -12 mA	
V _{OL}	Maximum Low Level	3.0	0.002	0.1	0.1	V	I _{OUT} = 50 μA	
	Output Voltage	3.0		0.36	0.44	V	V _{IN} = V _{IL} or V _{IH} (Note 3)	
							I _{OL} = 12 mA	
I _{IN}	Maximum Input	3.6		±0.1	±1.0	μA	V _I = V _{CC} , GND	
	Leakage Current							
I _{OLD}	Minimum Dynamic	3.6			36	mA	V _{OLD} = 0.8V Max (Note 5)	
I _{OHD}	Output Current (Note 4)	3.6			-25	mA	V _{OHD} = 2.0V Min (Note 5)	
Icc	Maximum Quiescent	3.6		4.0	40.0	μA	V _{IN} = V _{CC}	
	Supply Current						or GND	
V _{OLP}	Quiet Output	3.3	0.7	0.8		V	(Notes 6, 7)	
	Maximum Dynamic V _{OL}							
V _{OLV}	Quiet Output	3.3	-0.4	-0.8		V	(Notes 6, 7)	
	Minimum Dynamic V _{OL}							
V _{IHD}	Maximum High Level	3.3	1.7	2.0		V	(Notes 6, 8)	
	Dynamic Input Voltage							
V _{ILD}	Maximum Low Level	3.3	1.6	0.8		V	(Notes 6, 8)	
	Dynamic Input Voltage							

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: Incident wave switching on transmission lines with impedances as low as 75Ω for commercial temperature range is guaranteed for.

Note 6: Worst case package.

Note 7: Max number of outputs defined as (n). Data inputs are driven 0V to 3.3V; one output at GND.

Note 8: Max number of Data Inputs (n) switching. (n - 1) inputs switching 0V to 3.3V. Input-under-test switching: 3.3V to threshold (V_{ILD}) , 0V to threshold (V_{IHD}) , f = 1 MHz.

AC Electrical Characteristics

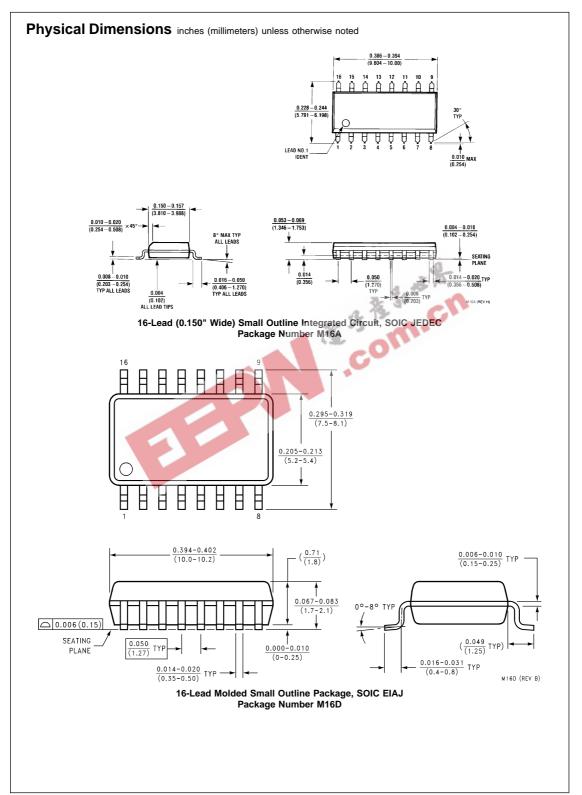
Symbol	Parameter	V _{CC} (V)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	2.7	1.5	84	16.2	1.5	19.0	ns
	S to Z _n	3.3 ±0.3	1.5	7.0	11.5	1.5	13.0	
t _{PHL}	Propagation Delay	2.7	1.5	7.8	15.5	1.5	17.0	ns
	S to Z _n	3.3 ±0.3	1.5	6.5	11.0	1.5	12.0	
t _{PLH}	Propagation Delay	2.7	1.5	8.4	16.2	1.5	19.0	ns
	Ē to Z _n	3.3 ±0.3	1.5	7.0	11.5	1.5	13.0	
t _{PHL}	Propagation Delay	2.7	1.5	7.8	15.5	1.5	17.0	ns
	\overline{E} to Z_n	3.3 ±0.3	1.5	6.5	11.0	1.5	12.0	
t _{PLH}	Propagation Delay	2.7	1.5	6.0	12.0	1.0	13.0	ns
	I _n to Z _n	3.3 ±0.3	1.5	5.0	8.5	1.0	9.0	
t _{PHL}	Propagation Delay	2.7	1.5	6.0	11.3	1.0	13.0	ns
	I _n to Z _n	3.3 ±0.3	1.5	5.0	8.0	1.0	9.0	
t _{OSHL}	Output to Output Skew (Note 9)	2.7		1.0	1.5		1.5	ns
toslh	Data to Output	3.3 ±0.3		1.0	1.5		1.5	

Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW (tosh) or LOW to HIGH (tosh). Parameter guaranteed by design.

Capacitance

Symbol Parameter		Тур	Units	Conditions	
C _{IN}	Input Capacitance	4.5	pF	V _C = Open	
C _{PD} (Note 10)	Power Dissipation	34.0	pF	V _{CC} = 3.3V	
	Capacitance				

Note 10: C_{PD} is measured at 10 MHz.





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